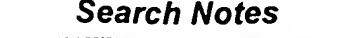


<b>Search Notes</b> 	<b>Application/Control No.</b> 10/510,036	<b>Applicant(s)/Patent under Reexamination</b> KIM ET AL.
<b>Examiner</b> Anne M. Hines	<b>Art Unit</b> 2879	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner